

<b>Notice of References Cited</b>	Application/Control No. 10/568,428		Applicant(s)/Patent Under Reexamination SHIGEMATSU ET AL.	
	Examiner Liam J. Heincer		Art Unit 1796	Page 1 of 1

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*	B	US-2003/0213979	11-2003	Nakajima et al.	257/200
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	L	US-			
	M	US-			

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#### NON-PATENT DOCUMENTS

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